

Search Notes

Application/Control No.

10/607,524

Examiner

Diane Yabut

Applicant(s)/Patent under
Reexamination

CHANG ET AL.

Art Unit

3734

SEARCHED

Class	Subclass	Date	Examiner
	Updated Search from 9/11/2006		
606	153	3/2/2007	DY
606	144	3/2/2007	DY
606	139	3/2/2007	DY

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search -- see attached Search History	3/2/2007	DY